

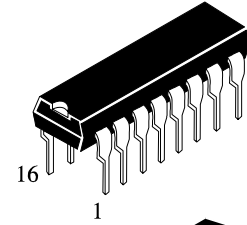
IN74ACT112

DUAL J-K FLIP-FLOP WITH SET AND RESET High-Speed Silicon-Gate CMOS

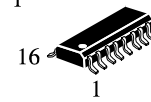
The IN74ACT112 is identical in pinout to the LS/ALS112, HC/HCT112. The IN74ACT112 may be used as a level converter for interfacing TTL or NMOS outputs to High Speed CMOS inputs.

Each flip-flop is negative-edge clocked and has active-low asynchronous Set and Reset inputs.

- TTL/NMOS Compatible Input Levels
- Outputs Directly Interface to CMOS, NMOS, and TTL
- Operating Voltage Range: 4.5 to 5.5 V
- Low Input Current: 1.0 μ A; 0.1 μ A @ 25°C
- Outputs Source/Sink 24 mA



N SUFFIX
PLASTIC



D SUFFIX
SOIC

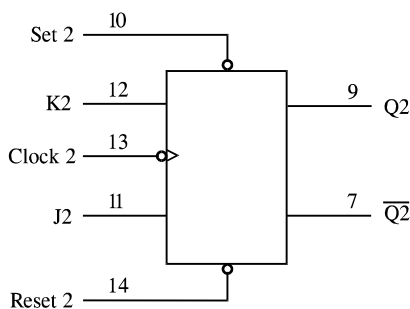
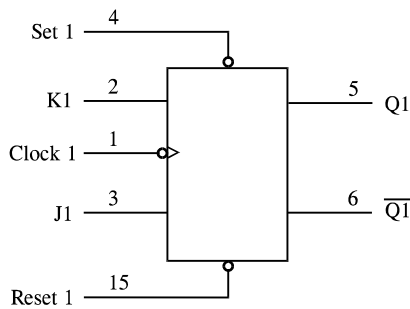
ORDERING INFORMATION

IN74ACT112N Plastic

IN74ACT112D SOIC

$T_A = -40^\circ$ to 85° C for all packages

LOGIC DIAGRAM



PIN 16 = V_{CC}
PIN 8 = GND

PIN ASSIGNMENT

CLOCK 1	1	16	V_{CC}
K1	2	15	RESET 1
J1	3	14	RESET 2
SET 1	4	13	CLOCK 2
Q1	5	12	K2
$\overline{Q1}$	6	11	J2
$\overline{Q2}$	7	10	SET 2
GND	8	9	Q2

FUNCTION TABLE

Inputs					Outputs	
Set	Reset	Clock	J	K	Q	\overline{Q}
L	H	X	X	X	H	L
H	L	X	X	X	L	H
L	L	X	X	X	L	L
H	H		L	L	No Change	
H	H		L	H	L	H
H	H		H	L	H	L
H	H		H	H	Toggle	
H	H	L	X	X	No Change	
H	H	H	X	X	No Change	
H	H		X	X	No Change	

* Both outputs will remain low as long as Set and Reset are low, but the output states are unpredictable if Set and Reset go high simultaneously
X = Don't Care

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MAXIMUM RATINGS*

Symbol	Parameter	Value	Unit
V_{CC}	DC Supply Voltage (Referenced to GND)	-0.5 to +7.0	V
V_{IN}	DC Input Voltage (Referenced to GND)	-0.5 to $V_{CC} + 0.5$	V
V_{OUT}	DC Output Voltage (Referenced to GND)	-0.5 to $V_{CC} + 0.5$	V
I_{IN}	DC Input Current, per Pin	± 20	mA
I_{OUT}	DC Output Sink/Source Current, per Pin	± 50	mA
I_{CC}	DC Supply Current, V_{CC} and GND Pins	± 50	mA
P_D	Power Dissipation in Still Air, Plastic DIP+ SOIC Package+	750 500	mW
Tstg	Storage Temperature	-65 to +150	$^{\circ}C$
T_L	Lead Temperature, 1 mm from Case for 10 Seconds (Plastic DIP or SOIC Package)	260	$^{\circ}C$

*Maximum Ratings are those values beyond which damage to the device may occur. Functional operation should be restricted to the Recommended Operating Conditions.

+Derating - Plastic DIP: - 10 mW/ $^{\circ}C$ from 65 $^{\circ}$ to 125 $^{\circ}C$

SOIC Package: - 7 mW/ $^{\circ}C$ from 65 $^{\circ}$ to 125 $^{\circ}C$

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Min	Max	Unit
V_{CC}	DC Supply Voltage (Referenced to GND)	4.5	5.5	V
V_{IN}, V_{OUT}	DC Input Voltage, Output Voltage (Referenced to GND)	0	V_{CC}	V
T_J	Junction Temperature (PDIP)		140	$^{\circ}C$
T_A	Operating Temperature, All Package Types	-40	+85	$^{\circ}C$
I_{OH}	Output Current - High		-24	mA
I_{OL}	Output Current - Low		24	mA
t_r, t_f	Input Rise and Fall Time * (except Schmitt Inputs)	$V_{CC} = 4.5 \text{ V}$ $V_{CC} = 5.5 \text{ V}$	0 10 8.0	ns/V

* V_{IN} from 0.8 V to 2.0 V

This device contains protection circuitry to guard against damage due to high static voltages or electric fields. However, precautions must be taken to avoid applications of any voltage higher than maximum rated voltages to this high-impedance circuit. For proper operation, V_{IN} and V_{OUT} should be constrained to the range $GND \leq (V_{IN} \text{ or } V_{OUT}) \leq V_{CC}$.

Unused inputs must always be tied to an appropriate logic voltage level (e.g., either GND or V_{CC}). Unused outputs must be left open.

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DC ELECTRICAL CHARACTERISTICS (Voltages Referenced to GND)

Symbol	Parameter	Test Conditions	V _{CC} V	Guaranteed Limits		Unit
				25 °C	-40°C to 85°C	
V _{IH}	Minimum High-Level Input Voltage	V _{OUT} =0.1 V or V _{CC} - 0.1 V	4.5 5.5	2.0 2.0	2.0 2.0	V
V _{IL}	Maximum Low-Level Input Voltage	V _{OUT} =0.1 V or V _{CC} - 0.1 V	4.5 5.5	0.8 0.8	0.8 0.8	V
V _{OH}	Minimum High-Level Output Voltage	I _{OUT} ≤ -50 μA	4.5 5.5	4.4 5.4	4.4 5.4	V
		*V _{IN} = V _{IL} or V _{IH} I _{OH} =-24 mA I _{OH} =-24 mA	4.5 5.5	3.86 4.86	3.76 4.76	
V _{OL}	Maximum Low-Level Output Voltage	I _{OUT} ≤ 50 μA	4.5 5.5	0.1 0.1	0.1 0.1	V
		*V _{IN} = V _{IL} or V _{IH} I _{OL} =24 mA I _{OL} =24 mA	4.5 5.5	0.36 0.36	0.44 0.44	
I _{IN}	Maximum Input Leakage Current	V _{IN} =V _{CC} or GND	5.5	±0.1	±1.0	μA
ΔI _{CCT}	Additional Max I _{CC} /Input	V _{IN} =V _{CC} - 2.1 V	5.5		1.5	mA
I _{OLD}	+Minimum Dynamic Output Current	V _{OLD} =1.65 V Max	5.5		75	mA
I _{OHD}	+Minimum Dynamic Output Current	V _{OHD} =3.85 V Min	5.5		-75	mA
I _{CC}	Maximum Quiescent Supply Current (per Package)	V _{IN} =V _{CC} or GND	5.5	4.0	40	μA

* All outputs loaded; thresholds on input associated with output under test.
 +Maximum test duration 2.0 ms, one output loaded at a time.

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AC ELECTRICAL CHARACTERISTICS ($V_{CC}=5.0\text{ V} \pm 10\%$, $C_L=50\text{pF}$, Input $t_r=t_f=3.0\text{ ns}$)

Symbol	Parameter	Guaranteed Limits				Unit
		25 °C		-40°C to 85°C		
		Min	Max	Min	Max	
f_{max}	Maximum Clock Frequency (Figure 1)	145		125		MHz
t_{PLH}	Propagation Delay, Clock to \bar{Q} or Q (Figure 1)	1.0	14.0	1.0	15.0	ns
t_{PHL}	Propagation Delay, Clock to \bar{Q} or Q (Figure 1)	1.0	14.0	1.0	14.5	ns
t_{PLH}	Propagation Delay, Set or Reset to \bar{Q} or Q (Figure 2)	1.0	12.0	1.0	12.5	ns
t_{PHL}	Propagation Delay, Set or Reset to \bar{Q} or Q (Figure 2)	1.0	12.5	1.0	13.0	ns
C_{IN}	Maximum Input Capacitance	4.5		4.5		pF

C_{PD}	Power Dissipation Capacitance	Typical @25°C, $V_{CC}=5.0\text{ V}$				pF
		35				

TIMING REQUIREMENTS ($V_{CC}=5.0\text{ V} \pm 10\%$, $C_L=50\text{pF}$, Input $t_r=t_f=3.0\text{ ns}$)

Symbol	Parameter	Guaranteed Limits		Unit
		25 °C	-40°C to 85°C	
t_{su}	Minimum Setup Time, J or K to Clock (Figure 3)	2.0	2.5	ns
t_h	Minimum Hold Time, Clock to J or K (Figure 3)	2.0	2.0	ns
t_w	Minimum Pulse Width, Clock (Figure 1)	5.0	6.0	ns
t_w	Minimum Pulse Width, Set or Reset (Figure 2)	5.5	6.0	ns
t_{rec}	Minimum Recovery Time, Set or Reset to Clock (Figure 2)	0	0	ns

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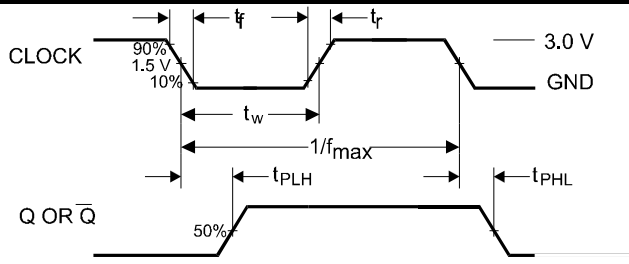


Figure 1. Switching Waveform

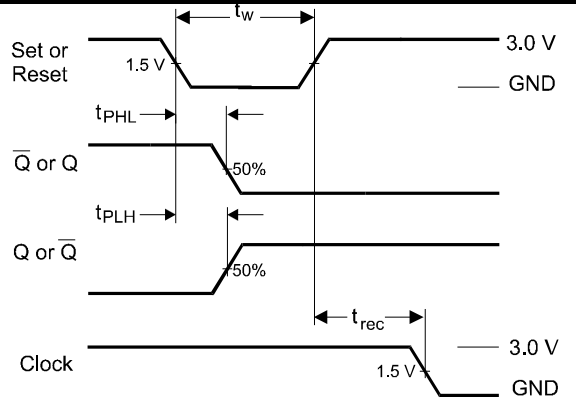


Figure 2. Switching Waveform

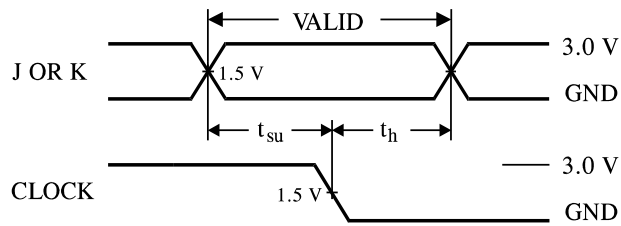


Figure 3. Switching Waveform

EXPANDED LOGIC DIAGRAM

